Subject Code/Title: PH3202 - PHY. for Engrand Eng. Unit: I - DIELECTRIC & INSULA PULARIZATION MECHANISMS :i) Loventz force due to electric field to Sp Separate the nucleus and the electron Dielectric polarization is the cloud from their equilibrium position displacement of changed particle under ii) Coulomb force - altractive force between the action of the esternal electric field, nucleus and electron aboud. There are jour type of palarization @ Let's be the i of= mechanisms as follows. i) Electronic Palanzation displacement by the '. displacement -u electron from the Core () ii) Ionic Polarization iii) Orientation Palarization Blueve X << R. iv) Space- Charge Polarization. Loventz force 1) Electronic Polarization: $\longrightarrow (2)$ Loventz Force =-ZeE Electronic polarization occurs Coulomb Sovce. due to displacement of the charge nucleus Coulomb force = Charge * field. $= Z Q * \frac{G}{4T5 x^2} - G$ and he charge electrons in opposite direction, when an external electric Q=> Total NO. q - he field is applied; they create a clipple Charge in Sphere moment in the dielectric. :. Q = Charge Derity × volume of sphere Without Feld: > Nucleo = -] Ze * 4 TI 15 +Ze Nucleus + Ze is A $\therefore Q = - \frac{Zex^3}{R^3} \longrightarrow Q$ surrounded by electron ## Substitute eqn. (1) in (3) cloud of charge - Ze with Sphere of Radius "R". Gulomb force = Ze - Zesc - Zesc - 4TTESSC R3 Charge Dennity of Here = -Ze Charged Sphere) = 4 TR² $= -\frac{Z^2 e^2 x}{4\pi \epsilon R^3} - 5$ Charge Dervilz = -3 Ze -At equilibrium; With Field Loventz force = Coulomb Force. Two phenomenon are occurs

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EnggTree.com Subject Code/Title: Let us assume a unit cell of Nach. $\therefore - ZeE = - \frac{Z^2 e^2 s}{4\pi \xi R^3}$ Duriady the electric field, "I is " be the distance noved by the s he E= Zex LTTER3 ions, due this dipole rurent is occurs Displaced; $x = 4 T \xi R^2 E \longrightarrow C$ Induced dipole y = Magnitude of change monent Displacement Displacement Directly proportional to $\mu_i = e(x_1 + x_2) \longrightarrow 0$ Appled Electric field. when an exclemal electric field is for - he ions for the ions applied to create a dipole moment in the Restoring force, For X, Resphering force, Forse dielectric. ... Included Dipule y = magnitude of charge morent * F= B1 21 F=B2×2 Displacenal. F= MWo X2. F= mwo x1 Me = Zesc. W.K.T. F= eE. Me = Ze. LTTER'E $eE = MW_0^2 S_2$ eE=mud x1 Me=LTTERE MedE ie Me= XoE Substitute I bx, in eqn. () X=4TER is alled Electronic Polaizal which is proper tional to value of sphere. $\mu_i = e \left[\frac{eE}{M \omega_i^2} + \frac{eE}{M \omega_i^2} \right]$ ii) Ionic Polarization: $A_i = \underbrace{e_E}_{N_2} \begin{bmatrix} h_1 + h_1 \end{bmatrix}$ Ionic Polarization due to the $\mathcal{L}_{i} = \mathcal{L}_{i} E$ displacement of Cations and anions from $: \alpha_i = e^{i \left[\frac{1}{m} + \frac{1}{m} \right]}$ its original possition. Janic Polarization - Inversely propultional te square of natural frequency (W)) +14 ×12 => Directly proportial li 24 Without field With field Roduced marsi (mit 1/m CHENNAL OF DEPARTMENT OF

Subject Code/Title: Unit: EnggTree.com iv) Space - Charge Polarization :-(i) Orientation Polanization : Space - Charge polarization occurs Polar moleculos which have due to diffusion of ions, along the field permanent dipole morant even in the direction and giving rive to redulitertanta absonce of an electric field. of charges in the dielectrics. 11- <- <-115 -2.L. Without field with field. With field. Without field When the field is applied, partie Total Field - Polarization: Portion align along the direction of field and negative portion align in the Talal Allanzability de = de + de + de opposite direction of the field. This kind $\alpha = 4\pi\epsilon_R^3 + \frac{e^2}{\omega_1}\left(\frac{1}{m} + \frac{1}{m}\right) + \frac{\mu^2}{2k_0T}$ of palarization is called as Orientation · P= NOVE Polanzation. $: R = NE \left[4TER^{2} + \frac{e^{2}}{WE} \left(\frac{1}{m} + \frac{1}{m} \right) + \frac{A^{2}}{3kT} \right]$ @ Langevin theory of paramagnetism, Intensity of Z = N/22B magnetisation J = 3KBT This equalion is Called "Lagevin-Debye Equation" @ Same principle applied to application of electric field. INTERNAL FIELD (ON) LOCAL FIELD Orientation $P_0 = \frac{N \mu^2 E}{3 k_0 T}$. CLAUSIUS - MOSOTTI EQN. :-P=NXE Long vange of Coulomb for a which do=> Orientation Palanzability; is created due to the dipoles are alled Internal field, it is responsible for $\mathcal{O}_0 = \frac{\mu}{3k_T}$ polarising individad aten or molecules Inversely propertional to Tenporaline. DEPARTMENT OF

EnggTree.com Subject Code/Title: Let us assume a dielectric raterial Here. E= E,+E2 Kept in an electric field, Consider an E1=0 imaginary Sphere of vadius 'V' is greater ->@ $\therefore E_{int} = E + E_3$ then the vadius of atom. A small elemental ving is Gut To find Ez: with thickness ds. In elemental ving Let "y" be the radius of small g' be the change Red, Direction. ring. on the area ds. Polarization, PN = Surface Area charge Area. P. = 2/ds. = P Q.D. q'= Pasodis. : Electric field intervity $E = \frac{q^2}{4\pi\epsilon^2}$ at c'due to q^2 $E = \frac{4\pi\epsilon^2}{4\pi\epsilon^2}$ + $E = \frac{\text{Pasods}}{4\pi \epsilon v^2} \longrightarrow 0$ The electric field at the Centre of the Resolving the intervity into two Sphere is called Internal field. Component $E_{int} = E_1 + E_2 + E_3 + E_4 \longrightarrow \mathbb{O}$ Ę Pavallel; Es = EG, O E, => field due to charge on the iplate. $\frac{1}{4\pi F_{r}} = \frac{Pastods}{4\pi F_{r}r^{2}}.$ E, => field due to palarized charge on the Perpendicular; Ey= E Sino plane surface. of dielectric Ez=> Field due to polarized charge induced : Ey= . PGJO Sind du at the spherical surface. EL => field due to atomic dipole invide the & The I'v Component are in Sphere Considered. opposite direction & Cancel to cachotter @ Tubl Surface area of clorental ving is "dra". CHENNAL DEPARTMENT OF

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$$F_{s} = F = \frac{P}{L_{s} \frac{C_{s} + O}{C_{s} \frac{1}{V_{s}^{2}}} dA = Crean france * The closes.$$

$$= 2\pi y \times ds$$

$$dA = Crean france * The closes.$$

$$= 2\pi y \times ds$$

$$dA = 2\pi y^{2} \sin \theta d\sigma$$

$$dA = 2\pi y^{2} \sin^{2} \theta d\sigma$$

$$A = 2\pi y$$

Subject Code Title: EnggTree	.comi:
Ling rice $dd = E Grod dS \longrightarrow (2)$ $G \Rightarrow \operatorname{Angle} \operatorname{between} \overline{E} \times d\overline{A}.$ $E \operatorname{bechi}_{i} \operatorname{feld}_{i} \operatorname{dt}_{i} = \frac{q}{2} \xrightarrow{1}_{i} \operatorname{T}_{i} \operatorname{feld}_{i} \xrightarrow{1}_{i} = \frac{q}{2} \xrightarrow{1}_{i} \operatorname{T}_{i} \operatorname{feld}_{i} \xrightarrow{1}_{i} = \frac{q}{2} \xrightarrow{1}_{i} \operatorname{T}_{i} \operatorname{feld}_{i} \xrightarrow{1}_{i} \xrightarrow{1}$	Let the charge tq be situated out; de the closed surjace at point O. Let "dw" be small solid angle for elementary Gne, Cit two element of closed surjace "d'S, & "d'Sz" at A & B. Magnitude of flux through "d'S" and "d'Sz are equal. Flux through "d'S, & inward while "d'Sz" is outward flux. : Total flux = $\frac{-9}{4\pi\epsilon} dw + \frac{9}{4\pi\epsilon} dw$ =0. "Total flux due to a Charge out; de is Zero." Trisulation BREAKDOWN in Solid, LIQUIDS & GASES: Dielectric = Great down voltages strength = Triethers of Dielectric
Charge Outride He Sphere:	When the strength of electric field applied to a dielectric exceed a critical value, very large current flow through it. The dielectric loses its insulating property and becomes a conductor. This phenomenon is called Dielectric Breakclown?
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Breakdown in Gaseous Dielectric & It occur due to ionization	- become conducting electron, anvent flows and is called Intrinsie Bradeclown an
Caused by Collision of electrons. Wh	en Zerer Breakclown.
a strong electric field is applied th	
accelerated free electrons act energy	Secondary Conduction electur
greater than the ionization of the	again dislodge some other bound
gas.	electrony in the valence band and this
@ Ili depends on Pressure,	process Continues as a chain reaction.
applied Electric field, Polarity of	Therefore vory large auvent flew through
electrodes, frequency of applied field	. The dielectric and hance Called as Avalanche
Breakdown is Liquids:-	Breakdown" 11) Thermal Breakdown:-
The impurities in a liquid	When a dielectric in subjected
have small conductive particle, it	to an electric field, heat is generated.
Create Conductive bridge between He	e The temperature inside the dielectric
electrodes. This leads to discharge.	increases and heat may produce breakdown
Breakclown in Solid:- There are various major	This type of breakcloun is known an Hernal breakdown. 111) Chemical & Electrochemical
mechanisms lead to dielectric	Repaledour
breakdown in solid, some of diele	When mobility of ions are increase insulation resistance decrease and hence
2.	dielectric become Conducting. This type of
i) Intrinsic Breakdown:	breakdown is called as chanical (is) Electro.
	contra marcavin.
When the electric field is applied	. IV) Discharge Breatedour
the valence band acquire sufficient	0
energy and go to Conduction band by	carily ionize and hence maduce large
Crossing the energy gap and hence	ionization Current Known as Discharge Broakdorwy
Compared and any	CHARTMENT OF SCIENCE AND HUMANUTIES

1040.00 March 20

the street of the

EnggTree.com Subject Code/Title: Mechanical axis - join the Centre side V) Defect Breakdown: of the herragon. Some didectric have defect such X- Cut Crystel :- x-asis. X-aris as Cracks, pares, blow holes etc. These Vacant pasition may have moisture (or) when the + X-asis Crystal is perpendicular 2 impurities which leads to breakdown X-Cut. to the X-aris. Colled as "Deject Breakdown". Y- Cut Crystal :when the crystal is y-al-is at perpendicular to PIEZOELECTRICITY & CRYSTAL Y- Anis y- Axis. Piezoelectricity: When mechanical stress is Y-Axia applied on dipolar crystal; electricity is @ when pressure (as mechanical force is applied along Certain asris produced due to the displacement of doole (mechanical Axis) w.r.t. optic axis of the This phenomenon is alled "piezoelectricity". Crystal, Her equal and apposite charges are The crystal which produce piezoproduced along perpendicular Axis electric effect and Converse piezo-electric (Electrical axis) w.r.t aptic axis of the effect are terred as "Piezo-electric Crystal" Crystal. This effect is Called "piezoclectic EJ. Quartz, Tournaline, Topaz. Effect. Quartz Crystel: & when potential difference It has an horogonal is applied along +++++++ shape with pyramid +-atis altached.at both ends. ->Y-Axin It Convict of 3 axest Certain assis (Electrical Pixis) wirt optic axis; joins the edge optic assis of the piezzelectric Crystal than of pyranids; Electrical Axis the Crystal Starts vibrate along & Ir asis (mechanical). This effect is alled join the Grner of Hexagon; Optic Axis (ZAXis) Inverse Piezoelectie Effect." CHINNAL DEPARTMENT OF

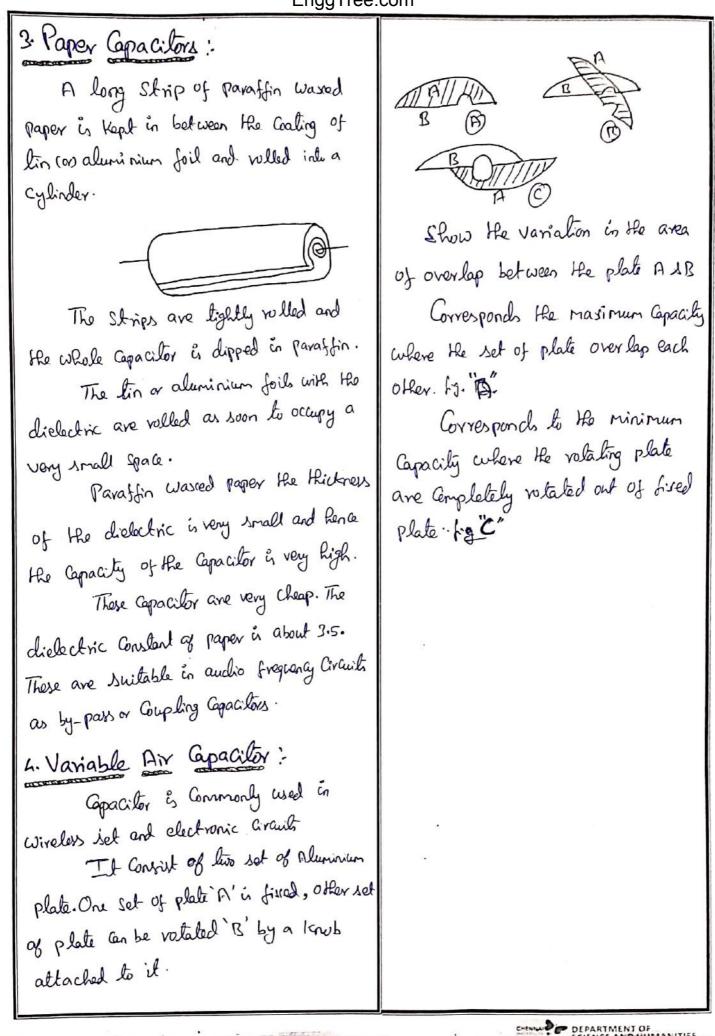
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Subject Code Title: Enga Subject Code Title: Enga Solver, Stran Gauges de They are also used as frequency Stabilizers and crystil Controlled Use Capacitor and crystil Controlled Use Class to produce ligh samitro infra-red detectors. CAPACITOR MATERIALS - TYPICAL CAPACITOR CONSTRUCTION: Dielectric material are used to nanufacture Capacitor of different Varges. Dielectric material such as Paper and plastic film, mica film, single Layor Ceramic, multiloger Ceramic, solid electrolytic are used in Capacitor. 1. Single & Multiloger Capacitors: The clicgranale representation of a single layor Capacitor. It Consult of this Ceramic click a plate placed in tetwan the metal electrodes. The cleads for the electrical Connection. are taken from the metal electrode. In order to preval the	degradation of dielectric Ceranic plate it is encapsulated in an epoxy Galing. The apacitance of Single layor Capacitor for an area, of the apacitance of the apacitor by Connecting N number of Ceranic plate in parallel Providing a sufficed Space. Sincer Laver Ceranic Capacitor with stocking of Ceranic plate in different layor is Known os "Multilayer Capacitor in the range of few Rundind microjande. Capacitor in the range of few Rundind microjande.
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The average k to of free dectrons
Crossing A

$$k = \frac{2}{3} k_B (T - dT)$$

 $k = \frac{3}{2} k_B (T - dT)$
 $k = \frac{3}{$

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Fermi Distribution function. Case (11) Definition: If T= OK at E>EF It is the probability of occupation Then F(E) = _____ of electrons among different energy levels at absolute temperature. = $\frac{1}{1+e^{\alpha V}}$ = $\frac{1}{1+\alpha V}$ It is given by $F(E) = \frac{1}{1+e^{(E-E_F)/K_BT}}$ F(E) = OThus 0% chance for the electrom to occupy the energy levels When E > Energy level to be considered. EF > Fermi energy level. case (11) If TYOK at E=EF KB-> Boltzmann Constant $F(E) = \frac{1}{1+e^{\circ}} = \frac{1}{1+1}$ T > Absolute Temperature. If FCE)=1, the energy level is $F(E) = \frac{1}{2}$ or F(E) = 0.5occupied by an electron. There is 50%. Chance for the If FCE)=0, the energy level is electrons to occupy the fermi Vaccant If F(E) = D.S, then there is 50. ethergy level chance for the electron to occupy. F(E) T T=0K. Case (1) FCE) If E<Ef at T=ok 1 Then FCE) = 1 1+0(E-EF)/keT = ______ 1+0^{(E-E}F)/0 Variation of E with respect to temperature. $=\frac{1}{1+e^{-\alpha}}=\frac{1}{1+e^{-1}}=1$ When T=OK, occupation is upho Ex When T>OK valence electrons FCE) = 1 got breakdown in its bond and Thus at T=0K, 100%. chance for exited to conduction band. the electrons to occupy the energy levels.

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Density of Energy States:-) $n + dn = \frac{1}{8} \left[\frac{4}{3} \operatorname{TI}(n + dn)^{3} \right] - (2)$ Definition! It is defined as the no. Hence, the no. of available energy of available energy states presented States between (n & n+dn) the per unit volume of a metal piece. energy interval E and E+dE. ZCE) dE = NICE) dE N(E) dE = $\frac{1}{8} \left(\frac{4}{3} \pi (n + dn)^3 - \frac{4}{3} \pi n^3 \right)$ No. of avaliable energy State between E& EHE Density of = 1 4 T (13+ 3ndn + 3ndn + dritte Volume of a metal. Energy states N(E)dE = $\frac{1}{8} \left[\frac{4}{3} \pi \left(3n^2 dn + 3n dn^2 + dn^3 \right) \right]$ "dn very small, neglecting the higher orders, N(E) $dE = \frac{1}{8} \left(\frac{4}{3}\pi(3n^2dn)\right)$ Let us consider a sphere inside a cubical metal piece of side 'a'. NCE) dE = Inda -3 + Here nx, ny, nz are the coordinate We know that axes. * n -> inner radius of the sphere. the energy of an electron in * = E and EtdE are the energy a cubical metal piece. of side a is of the inner and outer shell $E = \frac{n^2 h^2}{2m^2} - 4$ of the sphere. Differentiating eqn @ we have - + The sphere consists of no. of Shells, between inner and $dE = 2ndn.h^2$ outer shell each represents a Energy Cevel. $(i) ndn = \frac{8ma^{L}}{2k^{L}} \cdot dE - 5$ The no of available energy States within the thickness of the From eqn (4) Sphere of radius 'n' $n^2 = \frac{8ma^2}{12}E$ $n = \frac{1}{q} \left(\frac{4\pi n^3}{3} \right) - O$ $n = \left(\frac{8ma^2E}{L^2}\right)^{1/2} - - C$ 111'y the energy states within the Sphere of radius (n+dn)

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Hence eqn 3 can be written as N(E)dE = Inndn - 7 By substituting eqn (5 & 6 4) N(E) dE = $\frac{T}{2} \left(\frac{(8m)^{1/2}aE^{1/2}}{h}\right) \frac{8ma^2dE}{2h^2}$: N(E) $dE = \frac{T}{2} \frac{(8m)^{3/2} a^{3} E^{3/2} dE}{2} = \frac{(8m)^{3/2} a^{3} E}{2} = \frac{(8m)^{3/2} a^{3$ Here a3= V -> volume : Density of energy states ZCE) dE = NCE) dE $Z(E)dE = \frac{T(8m)^{3/2}}{\sqrt{E^{1/2}}dE}$ $Z(E)dE = \frac{\Pi}{4L^3} (8m)^{3/2} E^{1/2} dE - 9$ According to Pauli's exclusion Principle in each state 2 electrons can be accomodated. . ZCE) dE = 2×NCE) dE ". ZCE) $dE = & \times II (8m)^{3/2} E^{1/2} dE$ $Z(E)dE = \frac{T}{2L^3} (8m)^{3/2} E^{1/2} dE = 0$ Carrier Concentration in Metals:) The no of electrons per unit volume in a given energy interval is calculated by n_c = (zce) fce) de (1) by 2/3 We know that $Z(E) dE = \prod_{2L^3} (8m)^{3/2} E^{V_2} dE$

 $= \frac{11}{213} (8)^{3/2} (m)^{3/2} E^{1/2} dE$ $= \frac{1}{2} \left(4^{\frac{3}{2}} \left(2^{\frac{3}{2}} \right)^{\frac{3}{2}} \left(m^{\frac{3}{2}} \right)^{\frac{3}{2}} E^{\frac{1}{2}} dE$ $= \frac{11}{2h^3} a^3 (am)^{3/2} E^{1/2} dE$ $Z(E)dE = \frac{4\pi}{L^3} (dm)^{3/2} E^{1/2} dE - (2)$ If F(E)=1 for energy levels E=0 to E=Efo Then eqn (1) becomes $n_{c} = \frac{4\pi}{L^{3}} \left(dm \right)^{3/2} \int E^{1/2} dE$ $n_c = \frac{4T}{L^3} (am)^{3/2} \left(\frac{E^{3/2}}{3/2} \right)^{\frac{1}{2}}$ $= 4\overline{11} (2m)^{3/2} \cdot \frac{2}{2} (E_{F_0})^{3/2}$ $n_{e} = \frac{8\pi}{3h^{3}} (dm E_{F_{o}})^{3/2} - (13)$ Fermi Energy:-From eqn (3), we know that the carrier concentration η_c . can be written as $n_{c} = \frac{8\pi}{2L^{3}} (a^{m})^{3/2} (E_{F_{0}})^{3/2}$ $\frac{3n_{e}}{8\pi} \frac{h^{3}}{(2m)^{3/2}} = \left(E_{F_{o}}\right)^{3/2}$ By raising power on bothsides $F_{F_0} = \left[\frac{3 n_c}{8 \pi} \frac{h^3}{(k m)^{3/2}} \right]^{2/3}.$ $E_{F_0} = \left[\frac{3n}{9\pi} \right]^{\frac{2}{3}} \left[\frac{h^2}{h^2} \right]$ (14)

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$m^{*} = \frac{h^{2}}{dk^{2}}$ Eqn (1) \rightarrow Effective mass of an electron is not constant, but depends on the value $d^{1}E$ dk^{2} Case(i): $\frac{d^{2}E}{dk^{2}} = +Ve$, $m^{*} = +Ve$ Case(ii) $\frac{d^{2}E}{dk^{2}} = -Ve$, $m^{*} = -Ve$ Case(iii) $\frac{d^{2}E}{dk^{2}} = -Ve$, $m^{*} = -Ve$	Instead of beginning with
(ase ciii) d'E ->more, m* is ligher	elec bind.
	Tight binding approximation:
Before discussing about the tight binding approximation, let us know about free electron approxi- mation. Free electron approximation:- In solids, ionic core which are tightly bounded to lattice location exists. The electrons are free to move throughout the solid. This is called the free electron approximation.	
In free electron approximation,	bands (Eg) are larger than the allowed
* The P.E of the e is assumed to be lesser than its total energy.	bands.
* The width of the band gap (Eg) are	* Therefore the interactions between the neighbouring atom will be week.
1 Have the allowed hand ((in)	
* The interaction between the neighbouring atoms will be very strong.	The interatomic distance increases and hence the wave functions
atoms will be very strong.	Will not overlap.
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Pià, Para, Ferro Magr	utic Effects	
Dia	Para	Ferro
(j) It & non-magnetic material consits of no-permanent dipoles	Temporary indgretic material, consits of permanent dupole.	Permanant magnetic material, consits of large No, of permanent dipoles.
(i) Dipoles are opposite to each other in the absence of external field. Net dipole moment is zero	Dipoles are randomly Oriented in the absence of external field. Net dupole moment is minimum	parallel to each other, in
(iii) In the presence of external field dupole allign opposite to the external field.	In the presence of external field dipoles allign parallel to the external field.	Here also, dipoles allign parallel to the external field.
than land susceptibility		Attracted maximum by the material. Bin >>> Bout Permiability (20) is very much greater then 1, susceptibility
is -ve μ<<1, χ=-ve vi)Independent on temperature	tver M>1, X=+ve Dependent on temperatur	n fve, M≫1, X = fve Dependent on temperature
(vii) At Veny low temp. Ît will be m' diamagnetic	Temp above maximum para mag. converted unto Dia mag. vi Icnown: as Qunie Temp.	Above curie temperature it is converted in to para materials
Ex: Bismulb, Gold,	tx: AL, pt.	EX: Fe, Ni, Co.

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Paramagnetism in the Conduction) while the energy of the spins opposite to B is vailed by the Electrons in metals) same amount. According to Langevin's theory the paramagnetic susceptibility is \uparrow^{B} 18=0 inversely proportional to the EF Fr temperature. Xat But in some metals Susceptibility As a result, the Fermi level is independent of temperature. of the two spin divibution Pauli explains that it is due Shift with respect to each otherto the free electrons, can orient and energetically unstable Only in two directions, either along Situation In order to acquire stable the magnetic field or against it. Configurations, the es lying near Consider a curve between the Fermilevel with antiparallel density of states versus energy at absolute zero of temperature. In this spins flup with the region of parallel spins centil the two curre litere are two parts, one Fermilevels become equal again have electron spin along z-direction No. of electrons which change and another have electron spin opposite to z direction. their direction Neff = 1ZCEF)MBB In the absence of external where Z(EF) -> Density of states field the distribution of electrons MB -> mag. moment of vi the two parts are equal. electron. :, Net mag moment of the The factor 1/2 is due to the fact electron gas is zero. that the density of states of When a mag. field (B) is One spin distribution is half of applied along z-direction, the the total density of the states. energy of the spins aligned parallel to B is lowered by the amount 40

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". After application of the	Since TE is normally very high, Nop is smaller than X by about two
field	NPO Strate which is in
No. of electrons 2. No. of electron	Orders of magnitude, which is in.
No. of electrons? No. of electron with spin pauallel I with spin anti- parallel.	agreement with experimental results.
since each flip increases the	Exchange Interaction:
magnetisation by 2 MB C from - 48	The Weiss theory of ferro-
to tub), the net magnetisation is	-magnetism explains about the
given by	moleculear field but it is not
o	possible to explain large value of
$M \approx N_{eff} \times 2\mu_B = Z(E_f) \mu_B^2 B$	internal field.
	To explain the large internal
The Pauli' Spin Susceptibility	field, Heisenberg gave an explanation
of the electron is B=MoH	which is based on the non magnetic
Xp= Mo MB Z(Ef) Do= M	interaction called exchange interaction
	Interaction called exchange interaction between electron.
From egn, we know that	These force appears in the
Xp is independent of temp.	form of spin-spin interaction
	and strength of the interaction
From FD distribution we	depends upon the interatomic
Obtain 3N	Separation. If the interatomic
$Z(E_F) = \frac{3N}{2E_F}$	distance is decreased, the electron
N > no. elec: per unit volume	spin are decreesed and the
$x = 3 \mu_0 N \mu_8^2 = 3 \mu_0 N \mu_8^2$	exchange force decreases and
$(3) \Rightarrow \chi_p = \frac{3\mu_0N\mu_B^2}{2E_F} = \frac{3\mu_0N\mu_B^2}{2\kappa_F}$	become anti parallel spins.
	According to Heisenberg theory,
Where $F_F = kT_F$	the change interaction between
$\chi_p = \frac{3}{2} \chi_F^T$	electrons in different quantum
	States lead to a lower energy
where $\chi = \frac{\mu_0 N \mu_B^2}{kT}$ Classical susceptibility	provided the spin quantum number
	of the both states are parallel.
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. The exchange interaction between SQUID SQUID stands for Superthe electrons is given by -Conducting Quantum Interference Eex = -2 Jij Si Sj Device. It is an ultrasensitive Where Jij -> The exchange integral instrument used to measure Very weak magnetic field of the , for the two atoms. Si -> Spin angular moments order of 10th testa. associated with its state. Principle: Si → Spin angular moments We know that a small associated with jth state. change in magnetic field produces A plot of exchange integral variation in the quantum flux. value (Jij) and the interatomic Description and Working distance (Yab) Magnetic field Yab -> interatomic · distance. Superconductor -) Josephson Junction) Yo → the orbital radius of electron .→ I ther Biasing ⇒ Josephson Jij Current Junchion-2 Ji Gd 0 A Sould consists of a Superconducting ring which can have magnetic fields of quantum From graph, 1. The value of Jij is the when values (1,2,3...) of flux placed Yab >3 (i) the exchange energy is in between two Josephson junctions -ve and hence the parallel orientation as shown in figure. is high. Due to this atom possess When the magnetic field is ferromagnetic properties (Ex: Fe, Co, Nig) applied perpendicular to the 2. The value of Juj 5-ve when plane of the ring, the current is Yab <0 (ie) the exchange energy is the induced at the two Josephson Junctions. The induced current and hence the atoms coming under this criteria possess anti-ferromagner produces the interference pattern Properties [Ex: Cr, Mn] and it flows arround the ring

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So that the magnetic flux in the	waves. A constructive interference
ring can have the quantum	Can be expected to occur at "B"
value of magnetic field applied.	Similar to the Optical anlogue
	as they travel through the same
Application	distance.
(1) SQUID can be used to defect	
the variation of Very minute magnetic	The constructive interference
Signals in terms of quantum flux.	
(i) It can also be used as	reduces the resistance of the ring.
(i) It can also be used as	
storage device for magnetic fux.	various methods of introducing a phase difference of TT between the
(iii) SQUID is useful in the study	two waves have been sugested. This
	leads to destructive interference
•	which in turn will increase the
	rosistance by reducing the current.
brain, heart etc.	
	An external voltage can
Quantum Interference Transistor-	Control the nature of interference
Electrone are made to	and the current. This device is
propagate through two arms of	expected to act as a high speed
the quantum wire ring as -	transistor.
Shown in the figure.	GIMR Devices - Magnetic Hard Disk,
	Drive wilt GMR Sensor;
A⇒	GMR sensors, which has a
	Very high magnetic sensitivity are
	used to read the data at greater
	Speed.
Suppose an electron wave	
enters the ring of from left to	Trinciple.
Note 1 1 Mar	In Hard Disk drives, the
	binary data in terms of zero's (o) and
'A' gets split up into two partial	one sci) are stored by inducing.

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magnetic moment in a thiri magklorking :-(writing) layer and GMR effect 18 used 1. Initially the current is as the principle to read the data in passed through the writing . element and a magnetic field HDD. Here Zeroco) represents missing is induced in between the gap of the inductive magnetic transition and one (1) represents transducer. transition in the medium. 2. During writing 1 the amplitude Construction:of current is lept Constant, and * The HDD consists of recording the direction of current is meduum made up of this layer of reversed. magnetic garnets grown over the 3. Due to reversal of current Substrate the GMR Sensor. the reversal of current, the magnetization orientation is * The substrate is made up reversed in the recording medium of ferrites and anti fernomagnetic (ie) from south -> North. materials. This is used as reading 4. When the induced magnetic element Field is greater than the Coercivity * The writing element is made of the recording media, then up of inductive magnetic transducer. data is recorded in the form of 1. * The writing element and the 5 Thus one (1) is stored as data GMR Sensor Shall be made to In the recording medium as a magnetic transition. slide over the recording media 6. When there is no magnetic In the longitudinal direction. transtition, then it is referred as Read write current Cero. 7. In this way o's & i's are GMR Sensor writing Stored in the recording meduins element-Reading / Reforing 0 Recording Medium T ↑ 4 个 > substrate



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1. GMR effect is the principle used to read/retrieve the data 2. When GMR sensor is moving hear the recorded meduin, then the resistance of GIMR SENSOr varies with respect to orientation of the magnetic moments. as follows. * When the layer are magnetised is parallel manner their the resistance is minimum, therefore maximum current flows. This is represents. the data as Dne (1) * When the layers are magnetised in antiparallel manner, then the resistance is maximum, therefore minimum (no current) current flows This is represents the data as zono 3. Therefore, with the help of the reading current, the zero's (o's) and one's (I's) can be retrieved from the magnetic hard disc. Advantages) * Very large storage capacity. A Compact in size. * Non diffusive & very sensitive in reading. Disadvantages) * HDD & slower than SSD * Consume more power of Data may be corrupted, due to thermal radiation DEPARTMENT OF SCIENCE AND HUMANITIES Downloaded from EnggTree.com

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By substituting and simplyfying : Eqn () can be written as $n = \frac{4\pi}{13} (am_e^{f})^{3/2} e^{Ef/k_BT} \int x^{1/2} e^{-(E_c + x)} k_{BT}$ He donsity of holes P= 2 (atmit kBT 10) $n = \frac{4\pi}{13} (ame)^{3/2} e^{Ef - E_c/k_BT} \int x'^2 e^{-x/k_BT} dx$ Expression for intrinsi? carrier concentration. Using gamma function As we know in intrinsic $\int x'^{2} e^{-x/k_{B}T} dx = \frac{\sqrt{\pi}}{2} (k_{B}T)^{3/2}$ Semiconductor at any température above Trok n=p=ni — 1 $n = \frac{411}{1^3} (2m_{e}^{*})^{3/2} e^{(E_{f} - E_{c})/k_{sT}} \frac{\sqrt{11}}{2} (k_{sT})^{3/2}$ Hence hxp= nixni= ni $n = 2 \left(\frac{2nm_e^* k_BT}{L^2} \right)^{3/2} \left(\frac{E_f + E_c}{k_BT} \right)^{3/2}$ Hence ni=n×p given by $n_{L}^{2} = 2 \left(\frac{2\pi m_{e}^{*} \kappa_{BT}}{L^{2}} \right)^{3/2} e^{\frac{(E_{f} - E_{c})}{K_{BT}}}$ Eqn (3) is the expression for the $2\left[\frac{2\pi m_{h}^{4}k_{B}T}{h^{2}}\right]^{3/2}\left(\frac{E_{V}-E_{f}}{k_{B}T}\right)$ density of electrons in a Conduction $n_{i}^{2} = 4 \left[\frac{2\pi k_{B}T}{h^{2}} \right]^{3} \left(m_{e}^{*} m_{h}^{*} \right)^{3/2} e^{\left(\frac{E_{v} - E_{c}}{k_{B}T} \right)^{3}}$ band. Density of Holes (P) It is given by $h_{i} = 2 \left(\frac{2}{L^{2}} \right)^{3/2} \left(m_{e}^{\dagger} m_{h}^{\dagger} \right)^{3/4} e^{-E_{g}/2k_{B}T}$ $\int dP = P = \int zce) de \left([1 - Fce) \right)$ (13) -Ð Egn (3) is the expression for the carrier concentration Here ACE) dE = 411 (amp) 2 e 2 dE of intrinsic Semiconductor. here $m = m_{h}^{\dagger}$ Density of Holes: E = EV-E. It is given by $\int dP = P = \int z ce de \cdot (1 + Fce)$ 1-FCE) = 1 - (E-EF)/KRT

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Hence $P = \frac{4\pi}{L^3} \left(2m_h^* \right)^{3/2} e^{\frac{E_v - E_f}{k_B T}} \frac{\pi h_c}{2} \left(k_B T \right)^{3/2}$ Here ZCE) dE = 41 (2mh) 3/2 E 1/2 dE $P = 2 \cdot \left(\frac{2\pi m_h^4 k_B T}{L^2} \right)^{3/2} = \left(\frac{E_V - E_F}{I c_B T} \right)^{3/2}$ Here m= mh E = E,-E The above equation is the 1- F(E) = 1 - (E-EF)/EBT expression for the density of holes in the valence Band. Egn O $P = \int \frac{4\pi}{h^3} (2m_h^*)^{3/2} (E_v - E)^{1/2}$ Extrinsic Semi Conductor CE-EF)/KBT Def: Impure Semiconductors are the one in which charge carriers $P = \frac{411}{L^3} (am_h^*)^{3/2} e^{-E_f/k_{BT}}$ generated by adding impure atoms (CEV-E)¹²e^{E/K}BT de to the pure semiconductors. Types -(2) These are classified into two types based on the type of impunity let ' (i) n type (penta valent impurity) $E_{V}-E=x$ When when $E_{v}-E=x$ $E_{v}-dv$ $E=E_{v}$ $E=E_{v}-x$ $E_{v}-(-dv)=x$ $E_{v}-E_{v}=x$ (i) p bype (Trivalent imparity) farrier Concentration - ntype Semiconductor dE= -dx | Evta = x X=0 x=du * The energy level diagram is shown Egn @ becomes in the figure. $P = \frac{411}{13} \left(2m_{h}^{*} \right)^{2} e^{-Ef/k_{BT}} \int_{x^{1/2}}^{x^{1/2}} \left(\frac{E_{v}-x}{k_{BT}} \right)^{2} e^{-\frac{1}{k_{BT}}} \left(\frac{2}{k_{BT}} \right)^{2} e^{-\frac{1}{k_{BT}$ CONDUCTION BAND $P = \frac{411}{h^3} \left(\frac{2}{m_h^2} \right)_{e}^{3/2} \frac{E_V - E_f}{k_{BT}} \int_{x^{1/2}}^{x^{1/2}} e^{-\frac{2}{h_BT}} dx$ Uging hamma Junction Ev VALENCE $\left(x^{1/2} e^{-x/k_{BT}} dx = \frac{\sqrt{\pi}}{2} \left[k_{BT}\right]^{3/2}\right)$ BAND The energy level of excess electron is called donor energy (evel (Ed) - This is located above band CHENNAL DEPARTMENT OF SCIENCE AND HUMANITIES

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$$\begin{aligned} |A|Kb & |Ka density of electrons \\ in the conduction band (n) \\ = n the Donov \\ =$$

By substituting eqn (in eqn() CONDUCTION BAND Ec we have $n = 2 \left[\frac{2\pi m_q^4 k_B T}{h^2} \right]^{\frac{1}{2}} exp \left[\frac{E_d + E_c}{2} + \frac{k_B T}{2} \log \frac{N_d}{2 \left[\frac{2\pi m_q^4 k_B T}{H} \right]} + \frac{N_d}{2 \left[\frac{2\pi m_q^4 k_B T}{H} \right]} \right]$ Eg EF EV VALENCE BAND $h = 2 \left(\frac{2 \pi m_e^4 k_B T}{h^2} \right)^{3/2} e_{x,y} \left(\frac{E_d + E_c}{2k_y T} + \frac{E_c}{k_B T} + \frac{1}{2} \log_2 \frac{Nd}{2 (2\pi M_y^4 k_B T)} \right)^{3/2}$ he know that the density of hours in the valence band. $h = 2 \left(\frac{2 \pi m_e^4 k_B T}{h^2} \right)^{3/2} exp \left(\frac{E_d + E_c - 2E_c}{2k_B T} + \frac{1}{2} \log \frac{N_d}{2k_B T} \right)^{3/2}$ $P = 2 \left(\frac{2\pi m_h^4 \kappa_B T}{h^2} \right)^{3/2} e^{(E_v - E_F)/k_B T}$ -0 $n = 2 \left[\frac{2\pi me^{2} k_{B} T}{h^{2}} \right]^{1/2} = \frac{E_{d} - E_{c}}{2k_{B}T},$ $e^{\log \left(\frac{Nd^{1/2}}{2k_{B}T} \right)^{3/2} \frac{1}{2}} \left(\frac{1}{2k_{B}T} \right)^{3/2} \frac{1}{2k_{B}T} \right)^{3/2}$ Ey -> Top energy level of valence Band Ea Acceptor Energy level Ef -> Fermi Energy level. Density of Electrons in the $h = 2 \left(\frac{2 \pi m_e^{+} k_B T}{h^2} \right)^{3/2} e^{\frac{E_d - E_c}{2 k_B T}} \frac{N d^{1/2}}{\frac{V_2}{2} \left(\frac{2 \pi m_e^{+} k_B T}{r^2} \right)^{3/4}}$ acceptor energy level is given by n= Na [FCEa] $h = \left(2 \text{ Md}\right)^{V_2} \left(2 \frac{TTme^{\dagger} \kappa_B T}{L^2}\right)^{H_4} e \left(\frac{E_d - E_c}{2 \kappa_B T}\right)$ $n_e = Na \frac{(Ea-Ef)}{14c}$ -0 (6)Since Ea-Ef >> KBT (Or) Ea-EF >> 1 Eqn () is the expression for : I+ e (Ea-Ef)/KBT N e CEa-Ef)/KBT Carrier concentration of n-type $n_e = N_a e \frac{(E_f - E_a)}{K_BT}$ Semi conductor, in Ferms P-Type Semiconductor) At equilibrium, The Energy Cevel diagram No, electrons in ? No of holes in the acceptor = valence band(ne) energy level (p) is shown in the figure Here the excess no. of hous $2\left(\frac{2\pi m_{h}^{*} k_{B}T}{h^{2}}\right)^{3/2} e^{\frac{(E_{Y}-E_{f})}{k_{B}T}} = N_{a} e^{\frac{(E_{f}-E_{a})}{k_{B}T}}$ from a new energy level (Fa) the acceptor level just below Conduction Band DEPARTMENT OF SCIENCE AND HUMANITIES

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 $\frac{e^{\left(\frac{E_{Y}-E_{f}}{k_{BT}}\right)}}{\left(\frac{E_{f}-E_{a}}{k_{BT}}\right)} = \frac{Na}{2\left(\frac{2\pi m_{h}^{+}k_{B}T}{h^{-}}\right)^{3/2}}$ = $exp \frac{EV-Ea}{2k_BT} + \frac{1}{2} \log \frac{1}{2(2\pi m_h^3 k_BT)^{3/2}}$ Eqn () can be written $e^{\frac{[E_{v}-E_{f}-E_{f}+E_{a}]}{|K_{B}T|^{2}}} = \frac{N_{a}}{2\left(\frac{2\pi m_{h}^{*}K_{B}T}{h_{a}^{2}}\right)^{2}} P = 2\left(\frac{2\pi m_{h}^{*}K_{B}T}{h_{a}^{2}}\right)^{2} e^{\frac{[E_{v}-E_{a}+1]\log}{2K_{B}T}} \frac{N_{a}}{2\left(\frac{2\pi m_{h}^{*}K_{B}T}{h_{a}^{2}}\right)^{2}}$ $e^{\left(\frac{-2E_{f}+E_{v}+E_{a}}{k_{B}T}\right)} = \frac{Na}{2\left(\frac{2\pi m_{h}^{*}k_{B}T}{h^{2}}\right)^{3/2}} \qquad p = 2\left(\frac{2\pi m_{h}^{*}k_{B}T}{h^{2}}\right)^{3/2} \cdot \frac{Ev-Ea}{2k_{B}T} \cdot \frac{(Na)}{2\left(\frac{2\pi m_{h}^{*}k_{B}T}{h^{2}}\right)^{3/2}}$ $P = (2N_{R})^{1/2} \left(\frac{2\pi m_{h}^{*} \kappa_{B} T}{h^{2}} \right)^{3/4} e^{(E_{V} - E_{A})/\kappa_{B} T}$ Taking log on boltsides, Eqn D is the expression for $-2E_{f} + E_{v} + E_{a} = \log \frac{1}{2\left(\frac{2\pi m_{h}^{+} k_{B}T}{L^{2}}\right)^{3/2}}$ the carrier concentration of 'P'type semiconductor. Rearranging Equation, Hall Effect :-Ma $E_{f} = \frac{E_{a} + E_{v}}{2} - \frac{K_{B}T}{2} \log \frac{1}{2} \frac{2\pi m_{a}^{*} K_{B}T}{12}$ When a conductor carrying a current (I) is placed perpendi--cular to a magnetic fieldcb) a The density of holes in the potential difference is produced. Ptype can be written by substituting inside the conductor in a direction -(6) equation (b) in eqn (magnetic field. $P = 2 \left[\frac{2\pi m_h^* k_B T}{L^2} \right]^{3/2} e \left[\frac{E_V - E_f}{k_B T} \right]$ This phenomenon is known as Hall effect" and generated voltage Here (EV-Ef) can be rearranged as is called Hall "voltage" Hall Effect in n-type Semiconductor follows $= \exp\left[\frac{E_V - \left(\frac{E_a + E_V}{2}\right) - \frac{k_BT}{2} \log \frac{N_a}{2\left(\frac{2\pi m_h^* k_BT}{2}\right)^{3/2}}\right]$ T = $e_{xp} \left[\frac{2E_v - F_a - E_v}{2K_BT} + \frac{1}{2} \log \left[\frac{N_a}{2\left(\frac{2\pi m_h^2 K_BT}{L_a}\right)^{3/2}} \right] \right]$ Face-1 CHINNAL DEPARTMENT OF

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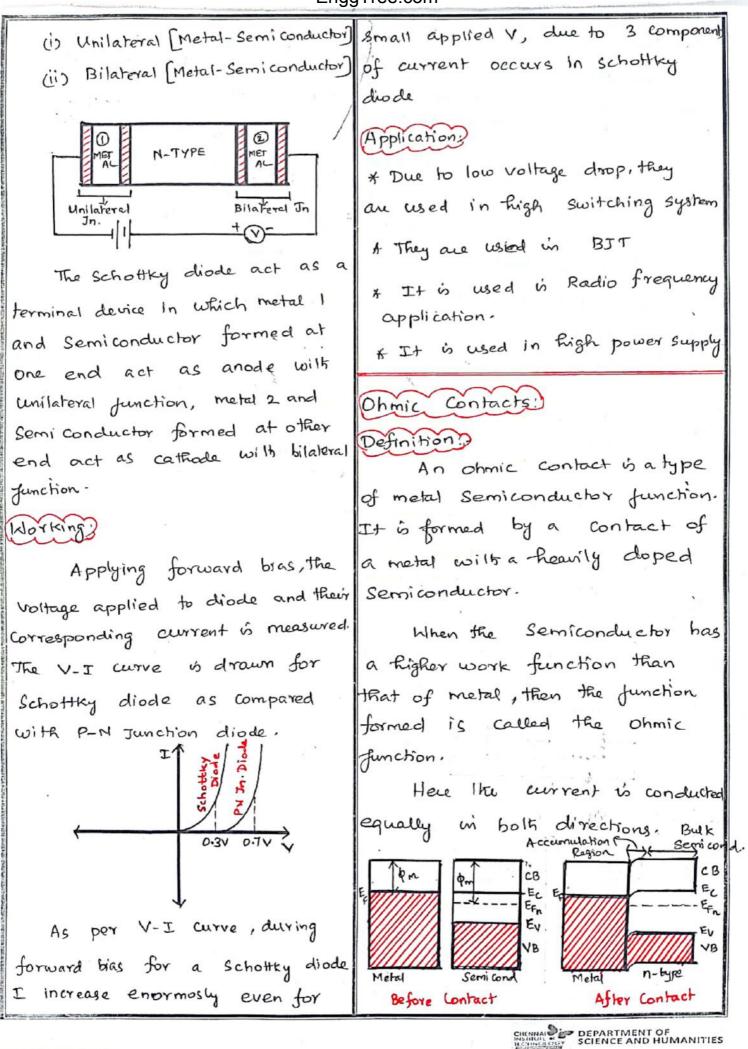
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Consider n-type semiconductor III'y in P-type semiconductor Current flow due to flow of holes in the form of rectangular slab. (the charge) Current (I) flow in X-direction Compare with n-type semiconductor magnetic field (E) is applied current density Jx = peu in z-direction, Due to Hall effect v= Jic -0 Voltage devolped along Y-direction Substitute eqn () in 3 (in fig). current flow due to Face-2 EH=RHJZB - 7 electron flow. RH = 1 De Electrons moving with velocity Face-1 b, experience downward force Hall coefficient interms of Hall voltage Force due to magnetic Z= Bev - () Hall voltage VH = EH t (8) where EH -> Hall field. Force due to potential }= efy -2 Substitute egn D in egn 3 difference VH = RHJSCBt - (1) At equilibrium ()=2 Area of the Sample A = thickness XBredly Bev = eEH Face - 2 A=bt Current density Jx = Ix EH = BO -3 we know that J2= Ix -10 Current density Substitute egn (D in egn (D) Jr = -nev VH = RHIZBE $\theta = -J_X - \Phi$ $V_{H} = \frac{R_{H} I_{X}B}{L} - O$ Substitute an (in egn 3) $\frac{R_{H}}{R_{H}B} - (2)$ $E_{H^2} B\left(\frac{-J_X}{he}\right)$ $E_{H} = R_{H}J_{X}B = 5$ where $R_{H} = -\frac{1}{ne}$ Eqn (gives hall coefficient in. -ve sign indicates interms of hall voltage. Elec field in -ve Experimental Determination of J. Hall coefficient Hall to efficient Yaxis $R_{H} = \frac{E_{H}}{J_{X}B}$ A semiconductor Slab of thickness 't' and breadly b' is SCIENCE AND HUMANITIES

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Electrical conductivity taken and current is passed through For p-type x-axis using battery. for n-type Mag. field along Semiconductor Semicond. 2-axis Je=neine -3 Oh = Pern $\begin{array}{c} \textcircled{2} \Rightarrow \textcircled{6} \\ \begin{matrix} \mathcal{M}_{h} = \underbrace{\sigma_{h}} \\ \hline 1 \cdot 1 \delta \\ \hline \end{array}$ D=> He = <u>Je</u> -1.18 V (Yaxis)) Semicond. Me = - J-18 Slab. Mh = 06 RH t - MA -4) -6 Application of Hall Effect: The slab is placed between (1) Used to determine whether the poles of an electromagneti. Magnetic material is p-type or n-type field is applied along Z-axis. The Hall Semiconductor. Voltage (VH) is measured by placing (ii) used to find the carrier. two probes at the centre of the top Concentration and bottom of the slab. $n = \frac{1}{eRu}$ By measuring Hall voltage, Hall (ii) used to find the mobility of Coefficient is determined from the Charge carriers formula $R_{H} = \frac{V_{H} b}{I_{*} B}$ Me = JE RH , Mh = Jh RH Mobility of charge Carriers We know that , Hall coefficient Schottky Diode:-Schottky diode is a $R_{tt} = -\frac{1}{nc}$ unilateral device, in which current The above expression is valid flow from metal to semiconductor Only for conductors, where the velocity in one direction. is taken as drift velocity. For n-type Semiconductor $R_{\rm H} = -\frac{1.18}{\rm he}$ Constmiction A schottky diode also $ne = -\frac{1.18}{R_{\rm H}} - 0$ called as schottky barrier diode. For p-type Semi conductor $R_{H} = \frac{1.18}{pe}$ $pe = \frac{1.18}{R_{H}}$ (2) It is made up of 2 junctions. CHANNEL DEPARTMENT OF SCIENCE AND HUMANITIES

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The current density is Working. Fermi levels of the metal and propertional to the potential across the function. Semiconductor are at different before contact. [Fig (1)] Ohmic contacts are nonpositions rectifying and show negligible After contact, at equilibrium voltage drop and resistance the electrons move from the metal irrespective of the direction to the empty states in the conduction and magnitude of current. band of semiconductor. ... An accumulation region near Applications the interface is appeared. (semi-The use of ohmic contact - conductor side) is to connect one semiconductor Fermi levels after contact are device to another, an IC or to connect an IC to its external shown in (fig(ii)]. terminals Accumulation region has a higher conductivity than the bulk Semiconductor due to higher concentration Ohmic contact behaves as a resistor conducting in both forward and revense brase. (Fig. fii). The resitivity is determined by the bulk resistivity of the semiconduct. N-TYPE characteristics 1-1 Negligible > ohmic Yoitage Contact CHENNAL DEPARTMENT OF SCIENCE AND HUMANITIES

	Subject Code/Title: PH3202-Phy for Engg	Tree.com Unit: IV - Optical Properties
alas dari ta yosantiin witea in witean	* Opto electronic devices such as light dectors (or) photo dectors Ore the devices which convert the light signal into electrical	 The p-n sequens are madeup of semiconductor material [silicon. germanium]. The interinsic sequence is a neubral, where it is at the centre of the p-type and n-type sequence and it is lightly cloped with n-material. Since the p-n sequence is seperated by an intrinsic sequence, where it is considered in the providence of the p-type of the p-typ

(1) P-i-n - Photo diode (PIN Dode) (P-i-n) photo diode. (ii) Avalarche Photo diode (APD) (iii) PN junction photo dector

- P-i-n- Photo Diocle (PIN Diocle)

* Principle:

· This Diode works in Reverse bias. Under reverse bias, light is made to fall on neutral region.

· Electron hole pairs are generated and accelerated by the external electric field, which secults in photo-current band, leaving a hole. * Construction:

· It consists of three segion Priound n.

converted into electrical energy CHERNAL

Optical Properties of Material

Intrinsic

* The PIN Diale is given very high

severse bias to attract le charge

carriers from le intrinsic region.

intrinsic region produces electron-tide

pais, by the transfer of electrons

from Valence band to conduction

* The movement of electrons in

re conduction bard creates flow of

charges. Hence light energy is

* The photon incident on the

Working:

Subject Code/Title: Unit: EnggTree.com Solar Cell: The two tormands connected * Pounciple: to the load resistance RL A solar cell is basically a P-N through the ohmic contacts. junction photo elicele, which converts Sun light solar energy (light energy) into JGILASS RING electrical energy. With larger 8 QĴ KL efficiency of photon absorption. HETAL CONTACT * The symbol of the solar cell * Working: P P Cattode. · Light radicition is allowed to fall on P-N junctions dide, without load resistance (Re). * Construction: · The photon energy is ● A solar cell is made up of a sufficient to break le covalent bond and produce electronheavily doped 'p' and "n" type material hole pais. @ The P-N dicele is packed is a · There electrons and holes can with glass window on top such quickly diffuses and reaches that light may fall upon Paral le depletion region. N type material. · Therefore the strong barrier @ The thickness of the p-region electric field existing in the and n-region is very small. junction Therefore charge carriers generated · The minority carries electrons is this stegion can easily in the p-side cross the barrier potential to seach N-side and diffuse to the junction. the holes in N-side more to the Nickel sing at the top and p-side. metal at bottom ast as terminals CHENNAL DEPARTMENT OF

Subject Code/Title:

of light. Photons

P-type

(Vo).

* Merits:

* Demorito:

* USES:

• Eco-fociendly

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Unit: LIGHT EHITTING DIDDE (LED). · The minority current is directly. * Definition: presentional to be illumination · LED is a semiconductor P-n junction dicde which converts P-type electrical energy to light energy under forward biasing. • The electrons and holes accumulate symbol. on either side of the junction, which gives rise to open-circuit volkge * Porinciple: • Injection luminescence is · Load Resistance RL is connected the porinciple used in LEDS. across the diode, neverse current @ The injection of electrons into Ir flows through the circuit. the p-seegion form n-segion Energy level Diagram makes a direct transition from conduction bard to valence N-type bard. The electrons secombines $\Theta \oplus \odot$ with holes and emits photens of energy Eg Outlize renewable energy * Construction: · pollubion force The p-n junction is formed
 ■ Life time durability high. by diffusion techniques by cloping silicon with GaAs crystal • Cost is very high. (seasonal energy O lohere, n-type is grown on a (Occupies more energy. Substrate and a p-type layer is deposited on it by diffusion. • power production. (used in artifical satellile and space probes.

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Subject Code/Title: Unit: EnggTree.com Biasing voltage in further. TITA (Anocle) -> SiOz increased, excess minority (Insulated layer) Carriers diffuse away from the junction and directly Substrate > Ke kuline secombine will be majority coaling carriers. (cattode). OTherefore electron-hole • To increase le radiative rerecombination process occurs, Combination, the thickness of n-laye tereby photon is emitted. is higher then the thickness of Energy level diagram: P'layer. O Ohmic Contacts are made by P-Lype alumentum is such a way that Band gap (Eg) $\oplus \oplus \oplus \oplus$ top layer "p" material is left N- type (F) (F) uncovered for the emission of valence band * Merits: light, where the Carrier recombinetion · Very Jast Response. Lakes place. · Cost is very low. * Working: · Smaller in Size. • Under forward biasing, Hajority · Long life time. charge carriers of n-type (electrons) * Demerils: moves to p-type as minority carrier power output is low Less Directional. @ similarly, majority charge Intensity is lesser tan laser. carriers of p-type (holes) moves to A-type as minority carries * Applications: · Used in display devices. @ By this process, excess of · Used in pilot light. minority carriers are injected Used ip indicator lamp. in both parol n stegion. This · IR LEDS used in whe -less is called minority carrier communication. injection, CHENNAL DEPARTMENT OF SCIENCE AND HUMANITIES

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LASER DIDDE : * Definition: P-type It is a specially PA Junction auput Jubricated P-n junction divel. n-type This diode emils laser light The photon emission is when it is forward-biased. stimulated in a very thin * Pounciple: layer of projunction. Recombination of electron-@ The end faces of the Pri hole pais leads to emission of junction are well polished and light is forward biasing known parallel to each otter. as recombination radicition. • It acts as an optical * Construction: seesonator through which the • The active medium is a emitted light comes out. P-n junction dide made from * Working: a single crystal of GaAs. • when the pn-junction is Jorward biased. @ The crystal is cut is the 2 8 8 8 form of platelet (0.5mm-thick news) Consists of two regions n-type N-Lype ()& p-type. @ Electrons & holes are injected • Metal electrones are unto junction stegion. connected to both upper & laser @ The sequen around junction surfaces of the S.C. diode. contains a large number of electrons in the conduction @ Forward bias voltage is band and holes in Valence band applied through metal electrocles.

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During recombination, light	* Applications of laser diodes;
photons are produced.	O Used in optical communi - cation.
O During Forward bias Idlage	- calion.
is increased, more photons	O Used in Barcocle stacder.
are emitted.	O Used in pointing industry.
O These photons brigger a	O used as writing head in
chain of stimulated recombineti	Disc drives.
more photons in phase barel	@ Used in Various Industry
forth & back of by two	applications such as cladding
polished surfaces of junction.	welding etc.
After gaining enough strength	OLED - Delganic LED:
Laser beam of wouldength	* Definition:
8400 À lis emetted from le	@ DLED are solid state devices
junction. $f=g=hc/\lambda$.	made up of this films of organic
* Merits:	molecules that produce light
• Compact in size.	with the application of electricity
O High efficiency.	@ It is also known as light
less power consumption.	emitting polymens (LEP) or
O Waveform is Continuous/ pulsed.	Dogenic electro luminescence
pulsed.	@ Thickness of these layers in
* Demirts:	around 100 - 500 nm thick.
@ Output has large divergence	* Pounciple:
poor coherence & Hono- chromatily	. An electron moves from the
chromatity	cattode to the emissive layer
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and hole moves from the anode to the conductive layer and they recombine to produce photons. * Construction: © It is constructed with different layers of polymens coated with Organic compound. Cattoole inductive inductive inductinductive induc	* Volorking:

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€ Herits: ⊙ It is thin & flexit	Je.	<u>')</u>	
 Light weight Larger field View 	¢.		
Emission is brighte normal light (LED:	n than s).		2 S S
* Demerits:			
Hanyacturing cost i	is high .	· · · · ·	~
 Easily clamaged. Haintainence is h 	igh.		
* Application;		1	
viadios, digital ca	· ·		
O Used in TV screen		•	8. J. 18
Computers displays, a	clverli -Sing		
@ Automative dash !	oards.	•	
O Used in flexible o boards.	Lisplan		
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Electro-Offic Hobulaios; * Electro-Optic Effect: The phenomeron in which the optical properties of a material charge in response to a vaxying electrical field is known as electro-optic effect and the crystals with special optical properties that allow an electrical signal to control arel, modulate a beam of light are known Electro-optic modulators. Types of electro-optic modulator * Intensity modulator * Intensity modulator * Anaplikude modulator * Anaplikude modulator * Anaplikude modulator * Phase implication modulator * Phase includator * Phase includa	Subject Code/Title: Engg	Tree.com Unit:
[littuium ridberte]. The orefractive	Eligy <u>ELECTRO-OPTIC MODULATIONS</u> , * Electro-Optic Effect: The phenomeron in which the optical properties of a material charge in desponse to a varying electrical field is known as electro-optic effect and the Crystals with special optical properties their allas an electrical signal to control and modulate a beam of light are known as Electro-optic modulators. Types of electro-optic modulator Base on type of the modulator are classified as * Intensity modulator * phase modulator * Amplikude modulator * Polasization modulator * Polasization modulator * Polasization modulator * Polasization modulator * Polasization modulator * Polasization modulator	index varies with strength of the applied electric field. Based on the linear electro-optic effect * Operation: * A voltage applied across the electro-optic (rystal. * Due to plane-polarized light propagating through the crystel to stesdred into two components. * The change in stetardation between two components is proportional to the magnitude of the electric field. * A crossed polarizer enalyzes the output beam, stesulting in intensity modulation. * Significance: • Hodify the properties of a travelling light wave. * Applications. * Replications. * Replications.
UCOLOUVE NUENDER AND HUMANITIES	[littuium risberte]. The sugractive	

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Electron cloud means. * Types of Optical switching: cee There are two types of optical switching. Electric field * P-i-n [Hulti Quantum Well] and optical properties of nanoparticle composition and medium · self electro optic effect (SEED) device. in which the particles are embedded. * The Quantum controlled * Application: Stark Effect [QCSE] * Superfast optical computers * Self Electro Optic Effects * Tumor killing cances [SEED] therapies * Laser for self-driving * Pounciple: The photocurrent flowing through the current including Switching Devices series resistor, changes the The opto-electronic switching voltage across the modulator, clevices are very useful for this infilmences its absorption computing and light activated and transmission. logic gates applications. * Ciscuit: * Definition; * In p- ? (Now) - n dicde, by the Switching refers to a reverse bias voltage, te phenomenon is which transmission tunneling current varies. of an optical field through a device * The photocurrent-bias voltage exhibits Negative differential. is switched among two or move possible states by optical resistance (NDR). DEPARTMENT OF

Subject Code/Title: Unit: EnggTree.com Kin Rs um Pout Pout = output electric pour Pin = input optical pasor * SEED corcuit with socies resistor Pin * Pin -> incident optical power * Increase of input optical Paul = I Rs is electric output power. pases increases the output * I is the photo current electric power due to ordinary flowing through resistance (Rs) photon absorption by the dide. * Operation * Photonic Switching can also * The photo current increases illustrated with two beams, cleer to recombination of one for transmission and one electrons and holes [turneling for control. of change carriers] * The negative bias across the diale decreases. The heavy hde absorption peak is shifted to higher energies. * Voltage drops P2Rs across the series desistor increases. * when the photo current decreases and correspondingly output electric power decreased. CHENNAL DEPARTMENT OF SCIENCE AND HUMANITIES

Subject Code/Title: PH3202 - PHYSICS Enge Ever Ever. Unit: V - NANO DEVICES.

 $= \frac{d}{dE} \begin{bmatrix} \frac{8\pi}{3} & (2ME)^{3/2} \\ 3 & P^{3} \end{bmatrix}$ DENSITY OF STATE FOR SOLIDS: $= \frac{f_{T}}{2} \frac{(2m)^{2}}{03} \frac{d(E)^{2}}{dE}$ BR: Election donvity is the number of electron per unit where in a $= \frac{\beta \pi}{3} \frac{2^{3/2} m^{3/2}}{\rho_{3}^{2} \left[\frac{1}{2}E^{3/2}\right]}$ material. It is determined by wring $=\frac{\beta \pi}{3}, \frac{2 \cdot 2^{\prime 2}}{\rho 3} \frac{M^{\prime 2}}{x} \frac{3}{2} E^{\prime 2}$ density as state. In solid, the total number of, $Z(E) = \frac{\xi \pi \sqrt{2} m^{3/2}}{\rho^3} \sqrt{E}.$ clectron energy states N with energy upto E is determined based on quantum Alt O K, the auto number of free electron per unit volume or electron density. Mechanics wring, $N = \left(\frac{\beta \pi}{2}\right) \left(2mE\right)^{2} \left(\frac{\alpha}{2^{3}}\right)$ from con D $\Pi_{e} = \frac{\beta \pi}{3} \left(\frac{(2mE_{F})}{\rho_{3}} \right)$ aftere a=> Volume of material The nanoparticle give Unique E=> Maximum Tregy level m=> maks of electron electionic propertes, so that the small R=> Planck's Constant volume material differ from bulk solid is No. of Energy State In= N per unit volume In= a³ the number of available energy state. $n = \left(\frac{\beta \Pi}{3}\right) \cdot \frac{(2mE)^{3/2}}{\rho^3} \longrightarrow \textcircled{B}$ Signifiance between fermi Trengy & Volume of the Material :-. Dentily of every state nothing but the Def It is defined as the highest number of available election every state argy level o'caupied by the electron per cinit volume per unit every. at ok in metal. in $Z(E) = \frac{dn}{dE}$ CHENNAL DEPARTMENT OF

Subject Code/Title: Unit: EnggTree.com direction and Confined in one direction Distribution of energy in solid have wide energy band whereas alter have thin, :. Z(E) = 417 mt. discrete energy state. Quantum Wire:from eqn. B 2/3 formi Energy of $F_F = \frac{R^2}{2m} \left(\frac{3n_e}{RT}\right)$ The armer an more freely Conductor aling one direction, the remaining two Here ne any variable, and others direction are Enfined. $z(E) = \frac{252}{2} m^{2} (E - E_{1})^{1/2}$ give Contant to. K. Er X né Quarter Dot: Therefere, ferri crergy of the Cendude All direction are Confined and just depends on the number of free election No direction the electron more as freely per unit valume, De. ENSITY OF STATE IN QUANTUM WELL, :. ZE) = f(E-E;) Plantum WIRE & QUANTUM DOT :-BULK STRUCTURE:-Density of $z(E) = \frac{\beta T \sqrt{2} r^{3/2} (E - E_{c})^{1/2}}{p^{3}}$ Every 3D-BULKwhere; E= Balton of Conduction Band. M=> Effective mars 9 Electron Quantum Well: The election Can more freely in two Enga

Unit: EnggTree.com Subject Code/Title: There are two type of quantum well lazer, i) Single Quarlum Well Layer. i) Multi Quartur well Later. Energy Quarter Mint Wire. Metal Cented oxide Set P-AlCars 00000 and g Gans N-ALGOA Energy Gans-Substate Quantum Dok -METAL Principle !-The Combination of electron from the QUANTUM WELL LASER:-Conduction band to the holes in valence band F) quantum well layer is a lover diode in which the active region produce Laser are narrow with quantum Confirment Construction :-Single quantum well later Consist occurs. Laser diale are formed in of a single active layer with different Compound somicerductor material and it con active every level. enit light efficiently. Hany Single quantum well are The wavelength of the light Coupled tigether to fer mult grantum depends on the width of the actue well laser. region.

EnggTree.com: Subject Code/Title: @ Hence, in multilayer quantum & In multi quantum well layer, the well layer, the efficiency is more than active layer are separated by the barrier the single layer of quantum well later. layer. Barner Active Active Active Advantages:-Layer-3 Layer-2 000 ⇒ It has higher efficiency 600 EC2 300 900 000 EC, 000 000 > Il- produces higher modulation 000 basd width. => It have dynamic spectral nis width, lower thresold arrent ÐÐÐ $\oplus \oplus \oplus$ BOB EVI BOB EV2 ÐÐÐ 000 $\oplus \oplus \oplus$ Application ! $\oplus \oplus \oplus$ @BOODGOBBBBBB of If is used for material prototing It is also employed in Laser Printing. K SINGLE LAYER ≯∖ € It is used in medical field such MULTI LAYER as Laser Scanning, medical therapy etc. Working !-@ Single fraquency source for tele Communi & Both Single and multilayer quantum Cation shall also be obtained using well laser, the recombination between the Quantum well later. Enduction and Valence band energy level. @ The electron from the Enduction BALLISTIC TRANSPORT: band energy level EC2 recombine with the in when mean free path of the electron hale in the valency band energy level EV; is lunger than the dimension of the @ In multi layer quantum well layer, medium through which the electron the photon emitted from active layer branch is called "Ballistic Transport" nultiplies in the second active layer and Explanation ! When the length L' of the further nultiplies in other layer and to on. anductor become much smaller than the CHENNAL

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Mean free path L' He transport is torned Ballistic, Hat the electron do not scatter during the time it takes to travel through the Cenductor for estampte, ballistic transport an be observed in a metal rand coive. Gondition of Ballistic Transport: The mean free path Can be	Tree.com
increased by reclucing the number of impurities in a Crystal or by lowering	
Ut temperature. (i) L << Ln (i) L < LQ. Where L => Length of the Enductor L=> Mean free path. LQ => Length over an electron trave before inelastic collision. The electron doesn't hit anything as it travel through the material, there is no momentum or phase relaxation. Mallintic transport is to where short - channel semiconducting FETS on Garbon nano tube transistors.	
	CHENNIL CE DEPARTMENT OF

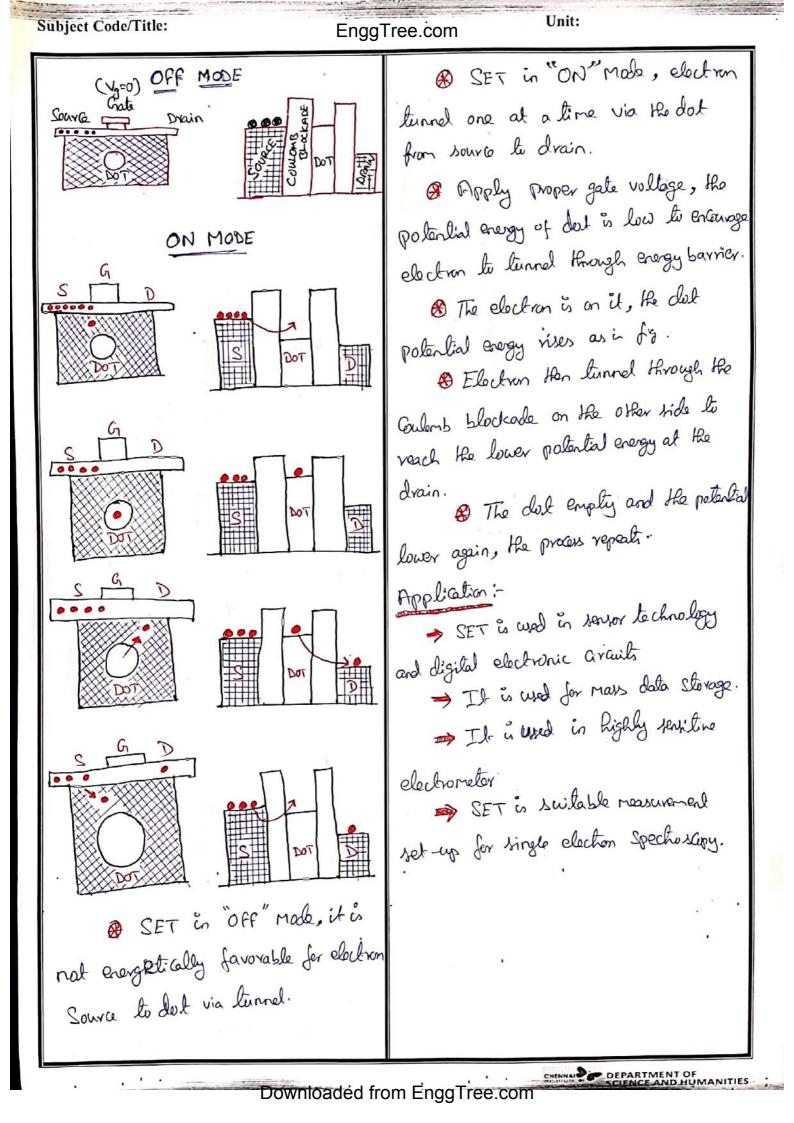
QUENTUM CONFINENT: The is a proless of reducing the size of a Cubic solid, so that the changy level inside beare describe @ The is observed when the size @ The is observed when the size @ The particle is too small Empare to @ The particle are free to @ The electron. @ The particle are free to @ The valid only small period @ The particle are Engineent @ The Corrier are Engineent @ The Corrier are free to rome & In Quantum well in Quantum w	Subject Code/Title: EnggTre	e.comi ^{t:}
QUANTUM STRUCTURE: When a bulk material reduced in its vize. If the reduced direction is in the order of few nenorraterials, then the structure is known as Quantum the structure is known as Quantum Structure". It is classified into 3 types based on direction. Is Quantum well is Quantum Wire. This Quantum Wire. This Quantum Wire. This Quantum Wire. This Quantum Wire. This Quantum Well: The Quantum Wire. This Quantum Well: The Quantum Wire. This Quantum Well: The Quantum Wire. This Quantum Wire. This Quantum Well: The Quantum Wire. The Quantum Wire. This Quantum Well: The Quantum Well: The Quantum Well: The Quantum Dot: The Q	The is a process of reducing He size of a Cubic Solid, so that the energy level inside before descrete. If is observed when the siz of the particle is too small Compare to the wave length of the electron. In which only small percent of electron free to more during Confinance & By boltom up or Top down	Quartum well are made from alternative layer of different samiGenductor or by deposition of very thin metal film. It is a large structure in which the Garrier particle are free to more in 2 D. The particle are Grifined in one Dimension, they are Considered as Quartum Confinement. Quartum Confinement of Carriers, the Confinement of Carriers, the
	QUANTUM STRUCTURE: When a bulk material reduced in its size. If the veduced dimension is in the order of few nenomaterials, the the structure is known as "Quantum Structure". It is classified into 3 types based on direction. IS Quantum well is Quantum Wire.	ii)Quartum Wire: To If 2D are reduced and one dimension venain large, the resulting structure, well. Quartum Wire: The Grivier are free to nove its trajectory along the wire. Quartum wire Structure are nanowire, nanoired and nanotude. Wire in ii) Quartum Dots: All three dimension are minimized, the rescelting
verain large, then we get a shirchure	venain large, then we get a structure	

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The sail of

· Unit: Subject Code/Title: EnggTree.com DENSITY OF STATE IN QUANTUM @ The Griers has only lenfined WELL, QUANTUM WIRE & QUANTUM DOT: state is not freely moving. @ IA has many thousand of ation, Carrier are Considered a single Bulk structure: Density of $z(E) = \frac{8\pi J \Sigma M^{*3/2}(E-E_{2})^{1/2}}{R^{3}}$ ation due to its peculiar properties. @ It is used in a quantum amputer and quantum dut later etc Ec=> Balton of Conduction Band Freigy M*=> Effective Mass of electron. Quantum Well : @ The electron Can move freely in DOT WIRE WELL two dimension and confined in only one BULK "Rectangular Nano Structure" direction. Density of $z(E) = \frac{A\pi m^*}{R^2} = \frac{1}{1} = 1, 2, 3$ State Quarter Wire: & It provide only one nen-Enfinement DUT WIRE WELL BULK direction, it can more only one direction; "Curvilinear Nere Structure" the remaining two direction are Confinal And the state for Charge Givrier. Density $g'_{Z(E)} = \frac{2\sqrt{2}m^{*}(E-E_{i})}{p}; i=1,2,2.$ R State WIRE DOT WELL BULK Three Quantum Structure" QUANTUM WELL . BULK Z(E) TE) CHENNAL DEPARTMENT OF Downloaded from EnggTree.com

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Subject Code/Title: EnggTree.com perpendicular to C-C bonds. CARBON NANDTUBE: [CNT]. III) Chival Structure; The heragonal lattice of Carbon & Simply graphile. A single ZIXA layer of graphile is Called Graphene. In chiral Shucture, C-C bond is When the graphene layer is inclined towards the airis of the tube rolled, Ho shucture is tube like and Properties of CNT: it is a single relacule, and is made "Electrical Properties:up of a hestagonal network of Grabently & Carbon nanotube are metallic bonded Carbon alon. or somi anducting depending on the diameter or chirality. Type of CNT: & Energy gap of seni anducting Three type of nanotube Chival Carbon nanotube is inversely Structure are Considered by rolling a proportional to the diameter of the tube. graphile sheet base on asis, @ The energy gap also varies along the lube axis and reaches i) Arm chair Structure 1) Zig-Zag Structure a minimum value at the tube end. 1) Mechanical Properties:mi) Chival Structure. & Structured based on aligned 1) Arm Chair Structure: Carbon - Carbon bond will ultimately When the axis of high strength: - tube parallel to @ One of the important C-C bond of the properties of nanatube is ability to Girbon Restagons. withstand extreme strain. is Zig-Zag Structure:-& It have high ultimate This structure are tentile - strength. iii) Physical Properties: formed by rolling graphenomist 18 The surface area of nanolube Sheet such the arris of the tube is not parallel to C-C bonds, its is the order of 10-20 m2/g which is CHENNAL DEPARTMENT OF

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higher Hen graphite. IV> Chemical Properties:-	SPINTRONICS:-
It is difficul to osidize	Spintvonics is a NANO technology which deals with spin dependent
them and the oneset of osridation in	properties of an electron instead of Charge
nonetube is 100°C higher than that of Carbon fibres.	dependent properties.
ins a result, imperature	Spintronics is based on the Spin of electron vather then its
is not a limitation in practical application of ranotubes.	charge. Electron exists one of two
V) Thermal proporties:	state Spin up and Spindown (or)
It have a high thermal Conductivity and the value increase with decrease	Clockwill and antichuck will represent
in diameter. Appli Cation:	O' and 1. N SI
@ It is used in development	
Of flat paral display. This used to make a computer	$+\frac{1}{2}$
Switching devices. The Can be used for Storing the	Spin up Spin Down.
Rydrogen, which is used in the development	
of fuel Cell. It Canbe used to increase	tiny magnet with north and south pale
the tensile strength of steel & It act as Catalysti for	The orientation of north-south airs depends on the particle aris of Spin.
some chemical reactions.	for ordinary material, the .
	magnetic moment ancel to each other,
	but in ferror ragnetic material, it

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exclubile magnetic propertes. This result in a permanent magnet. Working:- All Spintronic devices act is simple Schere; Information & stored into Spin as a particular Spin orientation (up or down). The Spins, being attacked to mobile electron, Gary information along a wive and the information of electron in Spintronic device we ful for manory Storage and magnetic sensor application. These are well for manory Storage and magnetic sensor application. These are well for guantian Computing, electron Spin will represent a bit (Gubit) of information. When a large scale net magnetic moment. SPIN- FET:- A Spin based field Effect Travis for is SPIN-FET.	G Q V3%0 G Q V3%0 G Q Q G Q G Q G Q G Q G Q G Q G Q G Q G
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reach the Collector.			
Is Vg>>>0, the pre	assion		
of electron is Controlled by	electric		
field to reach the Collector	with the		
same polarization.	1		
By Controlling the gale	voltage		
and polarity, the arment in	the		
Collector Con be modulated ju	uf like		
the MUSFET of the Convention	onal		
electronics.			
			•
11 P.			
		•	
		Cuthu	
LOW	nioaged from EnggTree	COM	HUMANIDES